

<b>Notice of References Cited</b>	Application/Control No. 10/635,195	Applicant(s)/Patent Under Reexamination KIM ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,420,272	07-2002	Shen et al.	438/702
	C	US-2001/0053610	12-2001	ATHAVALA et al.	438/710
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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